

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/637,215 WEISS ET AL.	
		Examiner David A. Rogers	Art Unit 2856	Page 1 of 1

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*	C	US-6,217,272	04-2001	Felsenthal et al.	414/217
*	D	US-6,281,655	08-2001	Poon et al.	318/649
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	U	"Arraychecker 3000" to PhotonDynamics, available on the Internet at < http://www.photondynamics.com >.
	V	"Arraychecker 3500" to PhotonDynamics, available on the Internet at < http://www.photondynamics.com >.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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